

GTS6923

P-CHANNEL WITH SCHOTTKY DIODE POWER MOSFET

BVDSS	-20V
RDS(ON)	50mΩ
ID	-3.5A

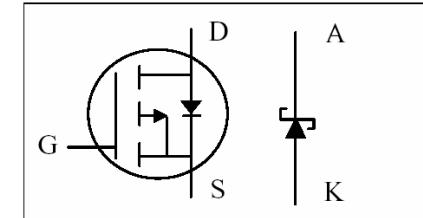
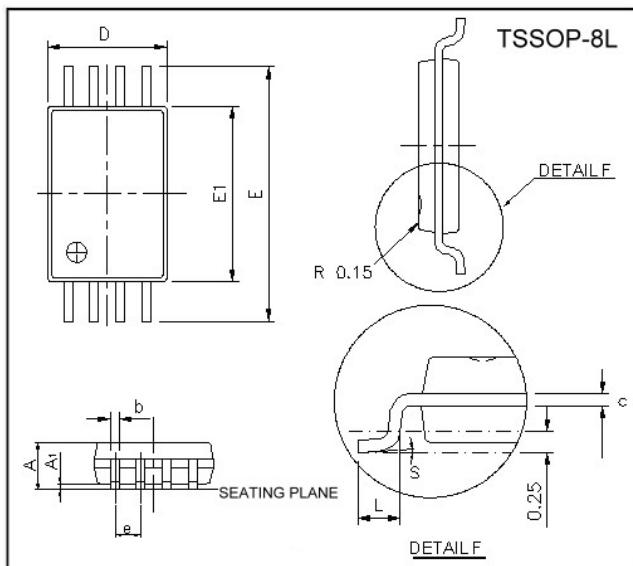
Description

The GTS6923 provides the designer with the best combination of fast switching, ultra low on-resistance and cost-effectiveness.

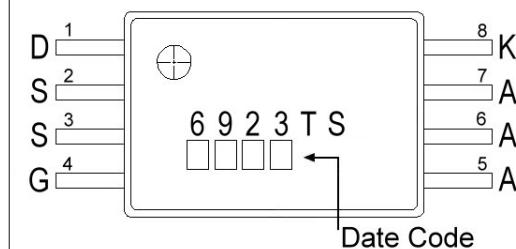
Features

- *Low on-resistance
- *Fast Switch Characteristic
- *Included Schottky Diode

Package Dimensions



Marking :



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	-	1.20	E	6.20	6.60
A1	0.05	0.15	E1	4.30	4.50
b	0.19	0.30	e	0.65	BSC
c	0.09	0.20	L	0.45	0.75
D	2.90	3.10	S	0°	8°

Absolute Maximum Ratings

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage (MOSFET and Schottky)	V _{DS}	-20	V
Reverse Voltage (Schottky)	V _{KA}	20	V
Gate-Source Voltage (MOSFET)	V _{GS}	±12	V
Continuous Drain Current ³ (MOSFET)	I _D @ Ta=25°C	-3.5	A
Continuous Drain Current ³ (MOSFET)	I _D @ Ta=70°C	-2.8	A
Pulsed Drain Current ¹ (MOSFET)	I _{DM}	-30	A
Average Forward Current (Schottky)	I _F	1	A
Pulsed Forward Current ¹ (Schottky)	I _{FM}	25	A
Total Power Dissipation (MOSFET)	P _D @ Ta=25°C	1	W
Total Power Dissipation (Schottky)		1	W
Storage Temperature Range	T _{stg}	-55 ~ +150	°C
Operating Junction Temperature Range	T _j	-55 ~ +125	°C

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance Junction-ambient ³ (MOSFET) Max.	R _{thj-a}	125	°C/W
Thermal Resistance Junction-ambient ³ (Schottky) Max.			

Electrical Characteristics ($T_j = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	BV_{DSS}	-20	-	-	V	$\text{V}_{\text{GS}}=0, \text{I}_D=-250\mu\text{A}$
Breakdown Voltage Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}} / \Delta T_j$	-	-0.03	-	V/ $^\circ\text{C}$	Reference to 25°C , $\text{I}_D=-1\text{mA}$
Gate Threshold Voltage	$\text{V}_{\text{GS}(\text{th})}$	-0.5	-	-	V	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=-250\mu\text{A}$
Forward Transconductance	g_{fs}	-	10	-	S	$\text{V}_{\text{DS}}=-10\text{V}, \text{I}_D=-3.5\text{A}$
Gate-Source Leakage Current	I_{GSS}	-	-	± 100	nA	$\text{V}_{\text{GS}}= \pm 12\text{V}$
Drain-Source Leakage Current($T_j=25^\circ\text{C}$)	I_{DSS}	-	-	-1	uA	$\text{V}_{\text{DS}}=-20\text{V}, \text{V}_{\text{GS}}=0$
Drain-Source Leakage Current($T_j=70^\circ\text{C}$)		-	-	-25	uA	$\text{V}_{\text{DS}}=-16\text{V}, \text{V}_{\text{GS}}=0$
Static Drain-Source On-Resistance ²	$\text{R}_{\text{DS}(\text{ON})}$	-	-	50	m Ω	$\text{V}_{\text{GS}}=-4.5\text{V}, \text{I}_D=-3.5\text{A}$
		-	-	85		$\text{V}_{\text{GS}}=-2.5\text{V}, \text{I}_D=-2.7\text{A}$
Total Gate Charge ²	Q_g	-	15.6	-	nC	$\text{I}_D=-3.5\text{A}$ $\text{V}_{\text{DS}}=-10\text{V}$ $\text{V}_{\text{GS}}=-4.5\text{V}$
Gate-Source Charge	Q_{gs}	-	2.1	-		
Gate-Drain ("Miller") Change	Q_{gd}	-	5.2	-		
Turn-on Delay Time ²	$\text{T}_{\text{d}(\text{on})}$	-	8.2	-	ns	$\text{V}_{\text{DS}}=-10\text{V}$ $\text{I}_D=-1\text{A}$ $\text{V}_{\text{GS}}=-4.5\text{V}$ $\text{R}_G=3.3\Omega$ $\text{R}_D=10\Omega$
Rise Time	T_r	-	9.4	-		
Turn-off Delay Time	$\text{T}_{\text{d}(\text{off})}$	-	66.4	-		
Fall Time	T_f	-	48	-		
Input Capacitance	C_{iss}	-	660	-	pF	$\text{V}_{\text{GS}}=0\text{V}$ $\text{V}_{\text{DS}}=-20\text{V}$ $f=1.0\text{MHz}$
Output Capacitance	C_{oss}	-	285	-		
Reverse Transfer Capacitance	C_{rss}	-	130	-		

Source-Drain Diode

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Forward On Voltage ²	V_{SD}	-	-	-1.2	V	$\text{I}_S=-0.83\text{A}, \text{V}_{\text{GS}}=0\text{V}$
Continuous Source Current(Body Diode)	I_S	-	-	-0.83	A	$\text{V}_D= \text{V}_G=0\text{V}, \text{V}_S=-1.2\text{V}$

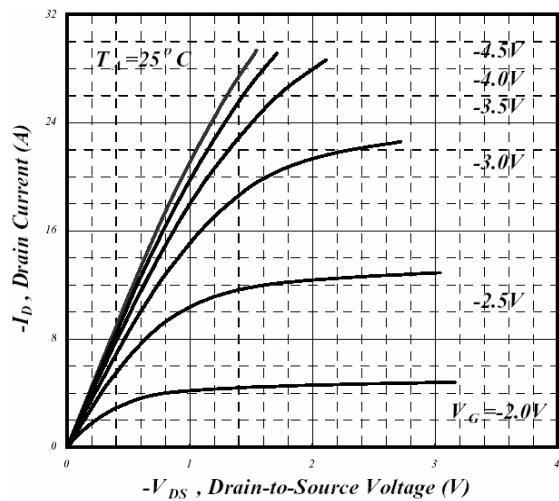
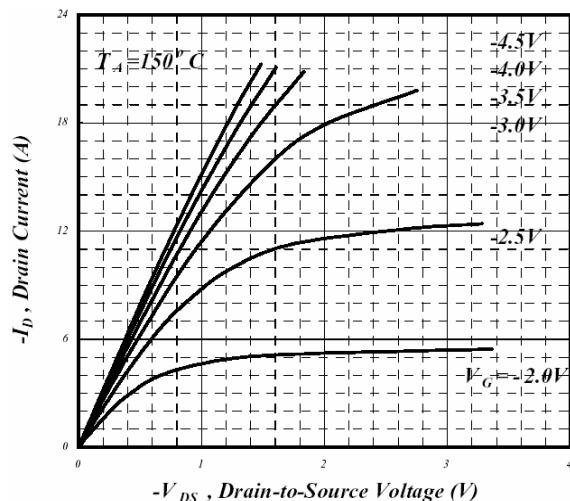
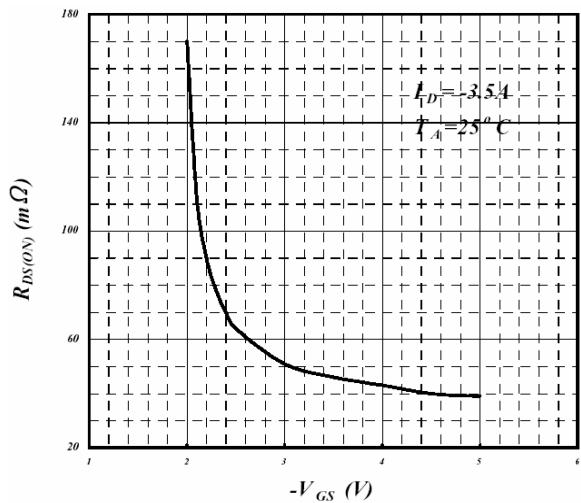
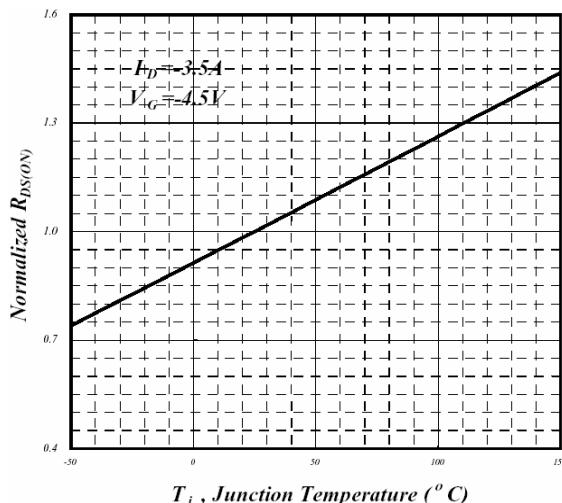
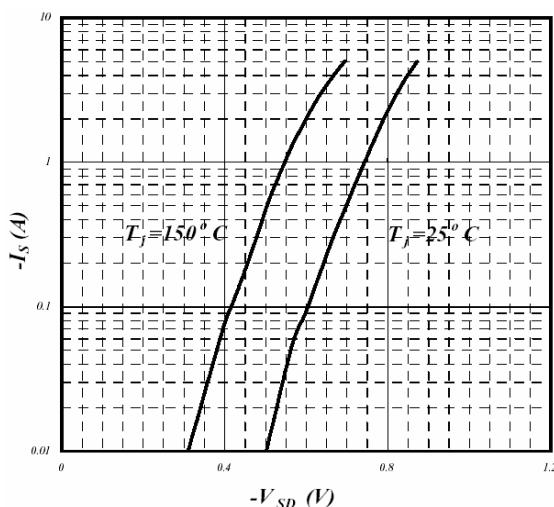
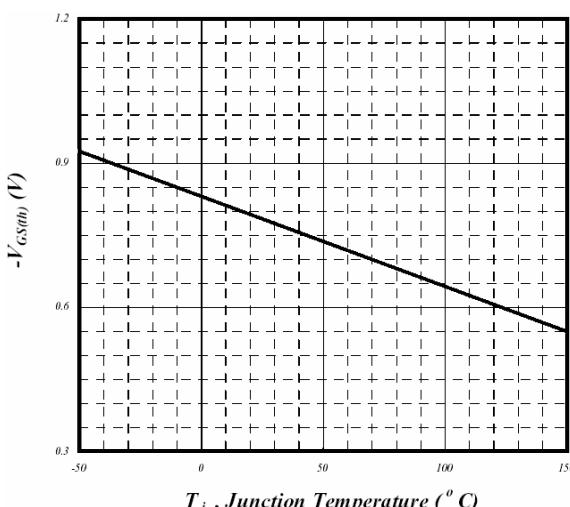
Schottky Characteristics @ $T_j=25^\circ\text{C}$

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Forward Voltage Drop	V_F	-	-	0.5	V	$\text{I}_F=1\text{A}$
Max. Reverse Leakage Current	I_{RM}	-	-	100	uA	$\text{V}_R=20\text{V}$

Notes: 1. Pulse width limited by Max. junction temperature.

2. Pulse width $\leq 300\text{us}$, duty cycle $\leq 2\%$.

3. Surface mounted on 1 in² copper pad of FR4 board; $208^\circ\text{C}/\text{W}$ when mounted on Min. copper pad.

MOSFET Characteristics Curve**Fig 1. Typical Output Characteristics****Fig 2. Typical Output Characteristics****Fig 3. On-Resistance v.s. Gate Voltage****Fig 4. Normalized On-Resistance v.s. Junction Temperature****Fig 5. Forward Characteristics of Reverse Diode****Fig 6. Gate Threshold Voltage v.s. Junction Temperature**

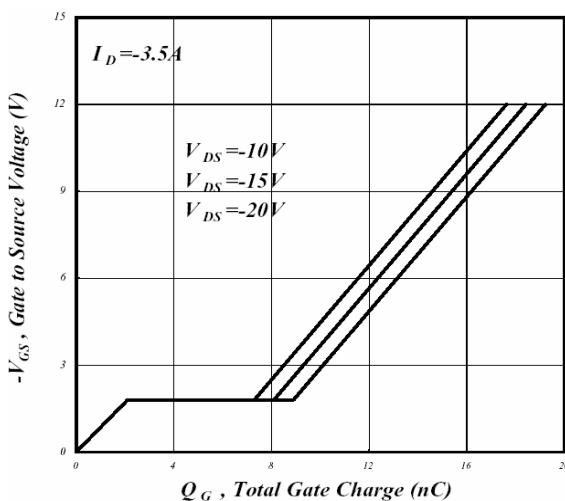


Fig 7. Gate Charge Characteristics

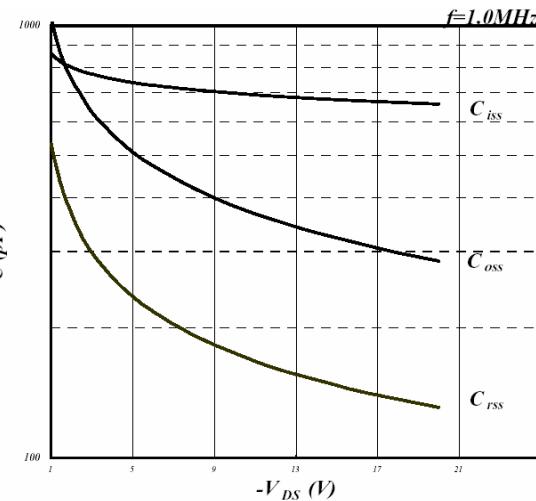


Fig 8. Typical Capacitance Characteristics

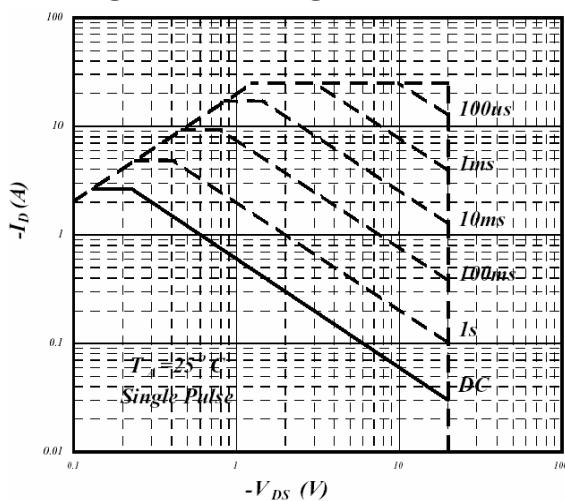


Fig 9. Maximum Safe Operating Area

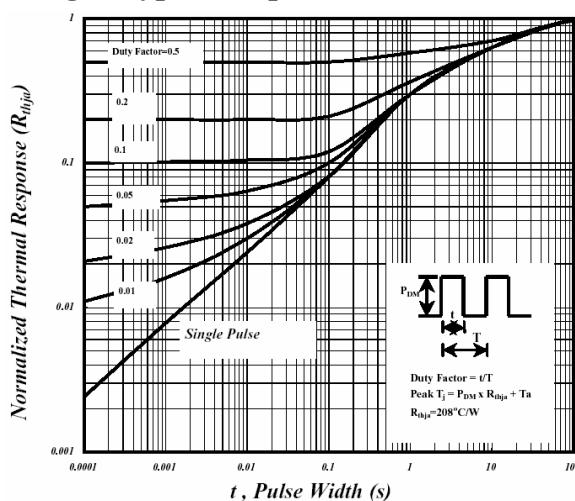


Fig 10. Effective Transient Thermal Impedance

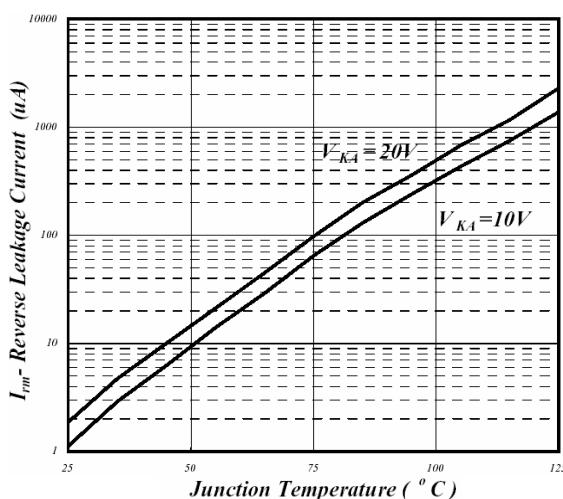
SCHOTTKY DIODE

Fig 1. Reverse Leakage Current v.s. Junction Temperature

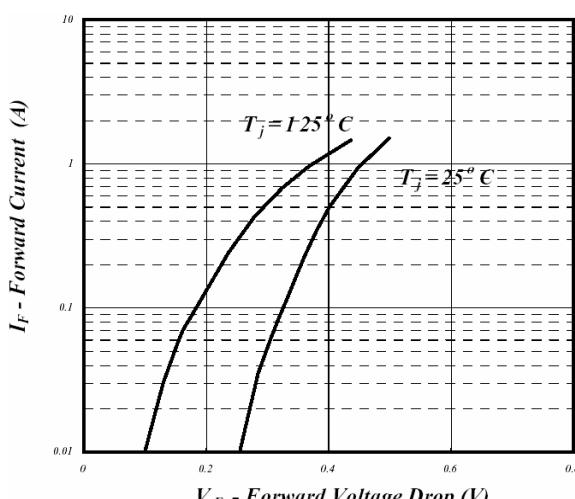


Fig 2. Forward Voltage Drop

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